

N- and P-Channel Logic Level Enhancement Mode MOSFET

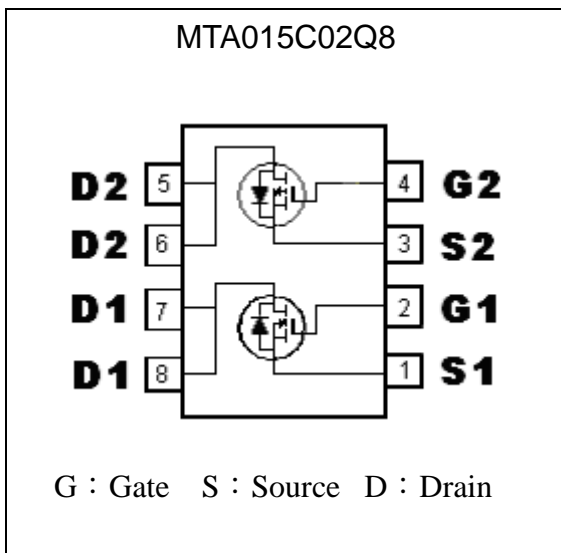
MTA015C02Q8

	N-CH	P-CH
BV_{DSS}	20V	-20V
$I_D @ T_A=25\text{ }^\circ\text{C}, V_{GS}=4.5\text{V}(-4.5\text{V})$	8.5A	-5A
$R_{DSON}(\text{typ.}) @ V_{GS}=(-)4.5\text{V}$	14.3m Ω	50.3m Ω
$R_{DSON}(\text{typ.}) @ V_{GS}=(-)2.5\text{V}$	19m Ω	66.6m Ω

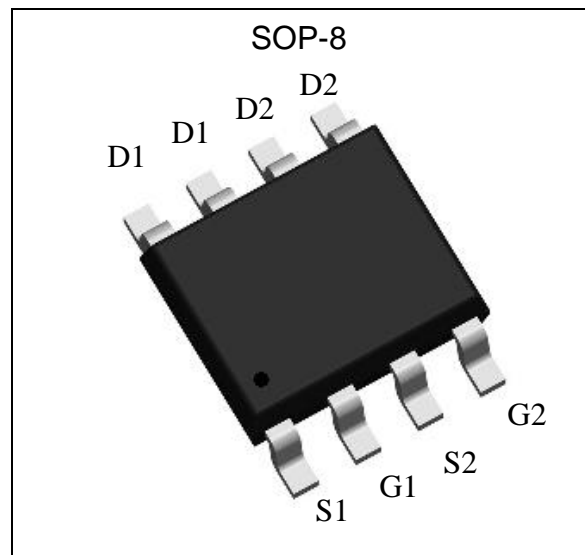
Features

- Simple drive requirement
- Low on-resistance
- Fast switching speed
- Pb-free lead plating and halogen-free package

Equivalent Circuit

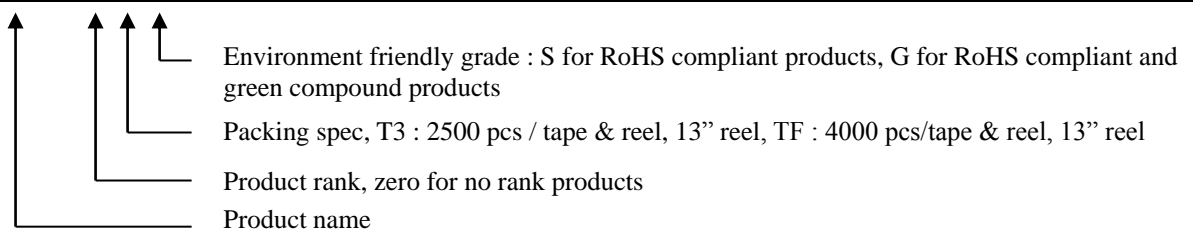


Outline



Ordering Information

Device	Package	Shipping
MTA015C02Q8-0-T3-G	SOP-8 (Pb-free lead plating and halogen-free package)	2500 pcs / tape & reel
MTA015C02Q8-0-TF-G	SOP-8 (Pb-free lead plating and halogen-free package)	4000 pcs / tape & reel





Absolute Maximum Ratings (T_C=25°C, unless otherwise noted)

Parameter	Symbol	Limits		Unit	
		N-channel	P-channel		
Drain-Source Breakdown Voltage	BV _{DSS}	20	-20	V	
Gate-Source Voltage	V _{GS}	±8	±8		
Continuous Drain Current (Note 2)	I _D	T _A =25 °C, V _{GS} =4.5V (-4.5V)	8.5	-5	A
		T _A =70 °C, V _{GS} =4.5V (-4.5V)	6.8	-4	
Pulsed Drain Current (Note 1)	I _{DM}	40	-30		
Power Dissipation (Note 2)	P _D	T _A =25°C	2.5		W
		T _A =70°C	1.6		
Operating Junction and Storage Temperature Range	T _j ; T _{stg}	-55~+150		°C	

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	R _{θJC}	25	°C/W
Thermal Resistance, Junction-to-ambient, max	R _{θJA}	50 (Note 2)	
Lead Temperature(1/16" from case, for 10 seconds)	T _L	275	°C

Note : 1.Pulse width limited by maximum junction temperature.
 2.Surface mounted on 1 in²copper pad of FR-4 board, pulse width≤10s.

N-Channel Electrical Characteristics (T_C=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	20	-	-	V	V _{GS} =0V, I _D =250μA
V _{GS(th)}	0.5	-	1.3		V _{DS} =V _{GS} , I _D =250μA
I _{GSS}	-	-	±100	nA	V _{GS} =±8V, V _{DS} =0V
I _{DSS}	-	-	1	μA	V _{DS} =18V, V _{GS} =0V
	-	-	25		V _{DS} =18V, V _{GS} =0V, T _j =125°C
*R _{DS(ON)}	-	14.3	20	mΩ	V _{GS} =4.5V, I _D =8A
	-	19	40		V _{GS} =2.5V, I _D =5.2A
*G _{FS}	-	7.6	-	S	V _{DS} =10V, I _D =3A
Dynamic					
C _{iss}	-	804	1045	pF	V _{DS} =10V, V _{GS} =0V, f=1MHz
C _{oss}	-	99	135		
C _{rss}	-	87	115		
*t _{d(ON)}	-	9.2	11	ns	V _{DS} =10V, I _D =1A, V _{GS} =4.5V, R _G =1Ω
*t _r	-	21.2	25		
*t _{d(OFF)}	-	38.6	45		
*t _f	-	8.6	11		
*Q _g	-	10	15	nC	V _{DS} =10V, I _D =5A, V _{GS} =4.5V
*Q _{gs}	-	1.3	2.6		
*Q _{gd}	-	2.9	6		



Rg	-	1.2	2.4	Ω	f=1MHz
Body Diode					
*Is	-	-	1.9	A	
*ISM	-	-	7.6		
*VSD	-	0.82	1.2	V	VGS=0V, Is=2.5A
*Qrr	-	8.3	-	nC	IF=1A, dIF/dt=100A/μs
*trr	-	3.1	-	ns	

*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

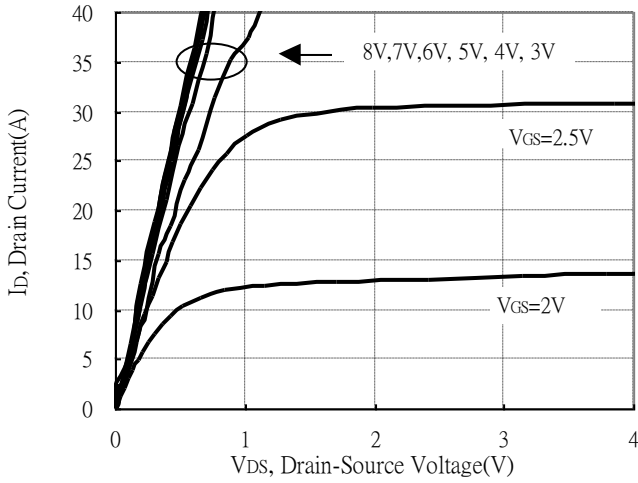
P-Channel Electrical Characteristics (Tc=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BVDSS	-20	-	-	V	VGS=0V, ID=-250μA
VGS(th)	-0.5	-	-1.3		VDS=VGS, ID=-250μA
IGSS	-	-	±100	nA	VGS=±8V, VDS=0V
IDSS	-	-	-1	μA	VDS=-18V, VGS=0V
	-	-	-25		VDS=-18V, VGS=0V, Tj=125°C
*RDS(ON)	-	50.3	72	mΩ	VGS=-4.5V, ID=-4.3A
	-	66.6	135		VGS=-2.5V, ID=-2A
*GFS	-	6.3	-	S	VDS=-10V, ID=-3A
Dynamic					
Ciss	-	679	890	pF	VDS=-10V, VGS=0V, f=1MHz
Coss	-	59	80		
Crss	-	56	75		
*td(ON)	-	10.6	16	ns	VDS=-10V, ID=-1A, VGS=-4.5V, RG=1Ω
*tr	-	20.8	25		
*td(OFF)	-	52	62		
*tf	-	8.6	11		
*Qg	-	7.8	12	nC	VDS=-10V, ID=-5A, VGS=-4.5V
*Qgs	-	1.3	2.6		
*Qgd	-	1.7	3.4		
Rg	-	13.9	20	Ω	f=1MHz
Body Diode					
*Is	-	-	-1.9	A	
*ISM	-	-	-7.6		
*VSD	-	-0.86	-1.2	V	VGS=0V, Is=-2A
*Qrr	-	7.2	-	nC	IF=-1A, dIF/dt=100A/μs
*trr	-	3.4	-	ns	

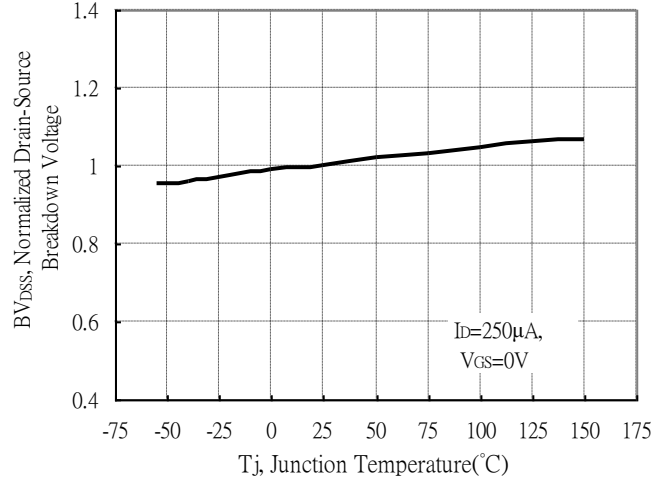
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

Typical Characteristics : Q1(N-channel)

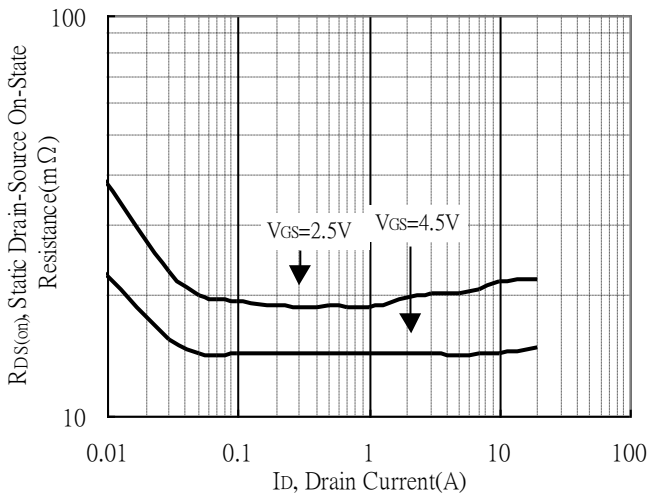
Typical Output Characteristics



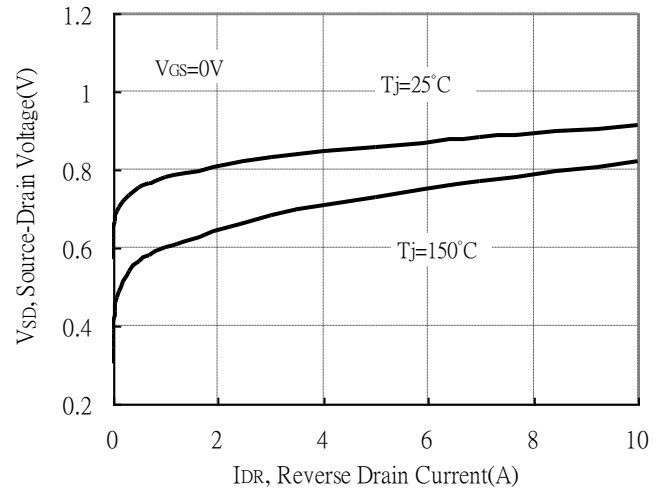
Brekdown Voltage vs Ambient Temperature



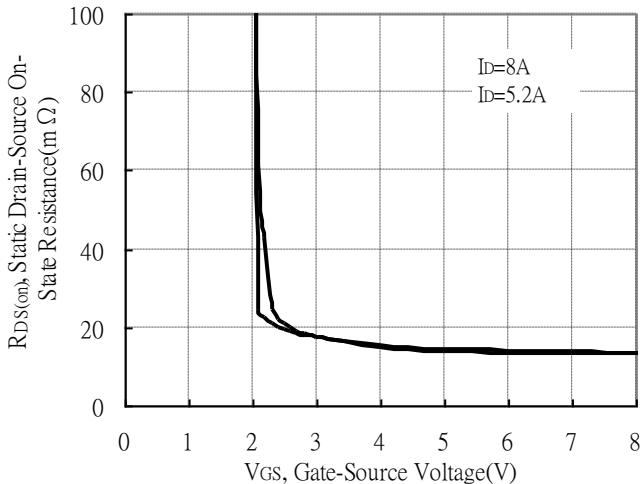
Static Drain-Source On-State resistance vs Drain Current



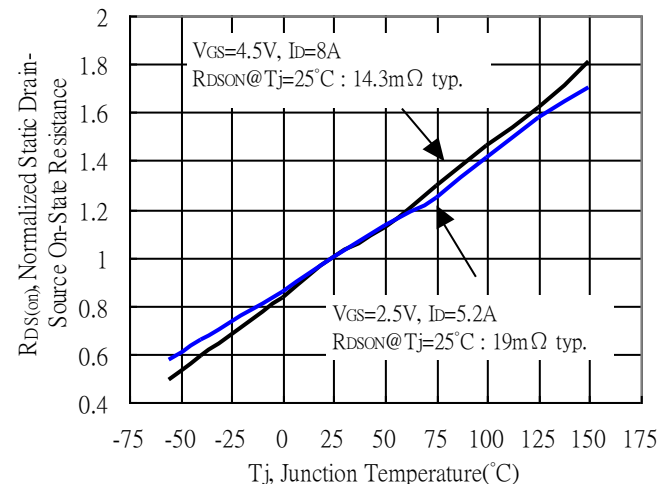
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

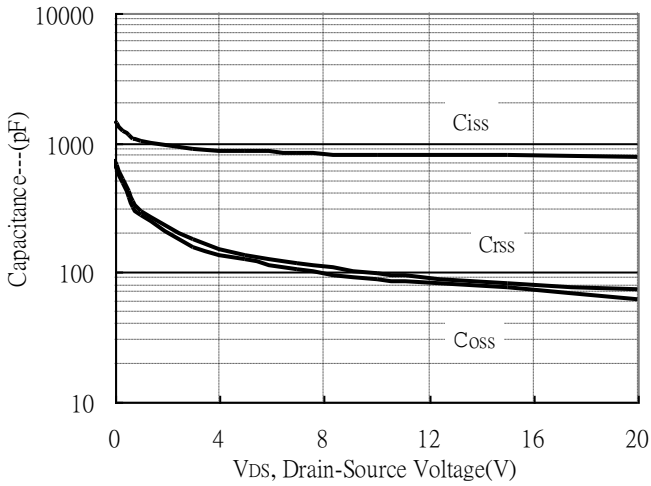


Drain-Source On-State Resistance vs Junction Temperature

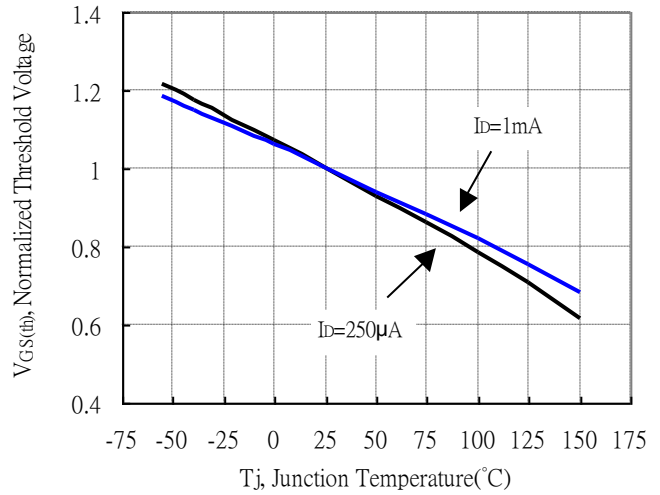


Typical Characteristics(Cont.) : Q1(N-channel)

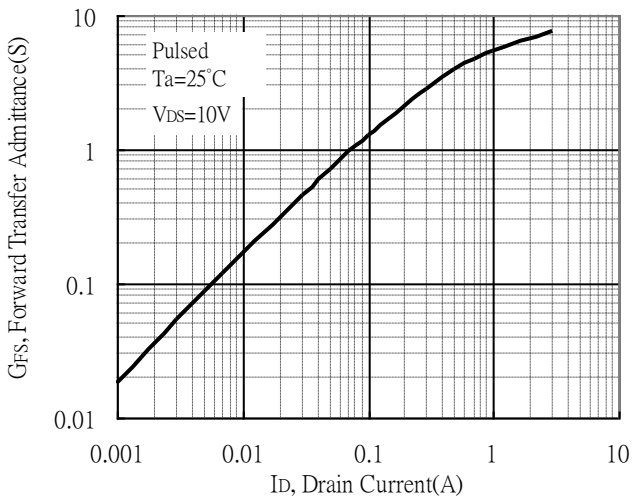
Capacitance vs Drain-to-Source Voltage



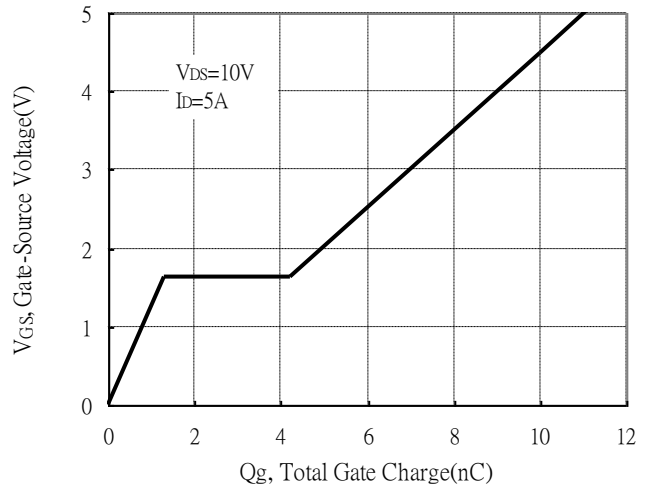
Threshold Voltage vs Junction Temperature



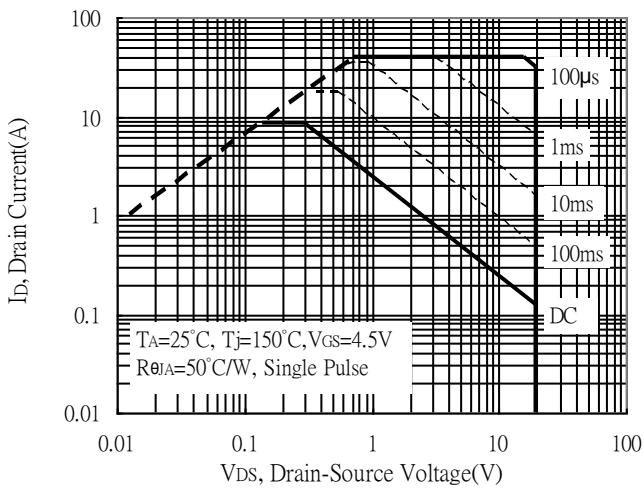
Forward Transfer Admittance vs Drain Current



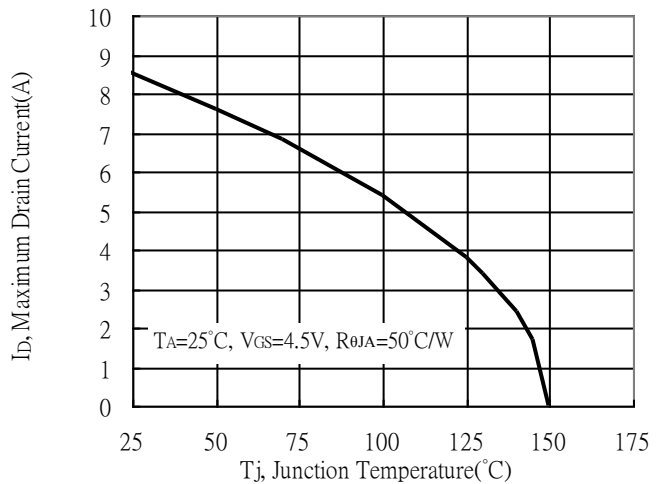
Gate Charge Characteristics



Maximum Safe Operating Area



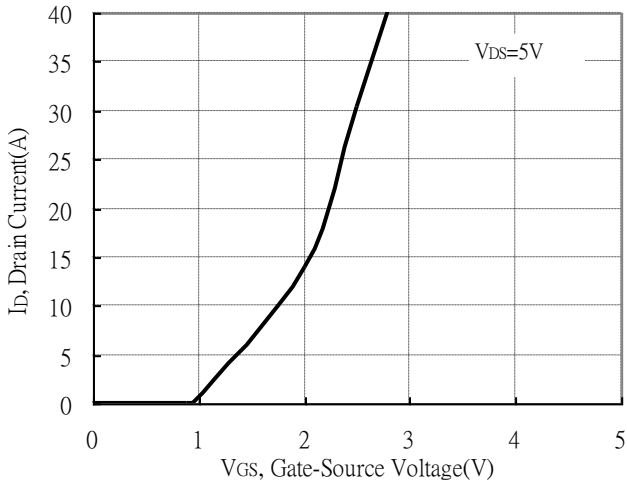
Maximum Drain Current vs Junction Temperature



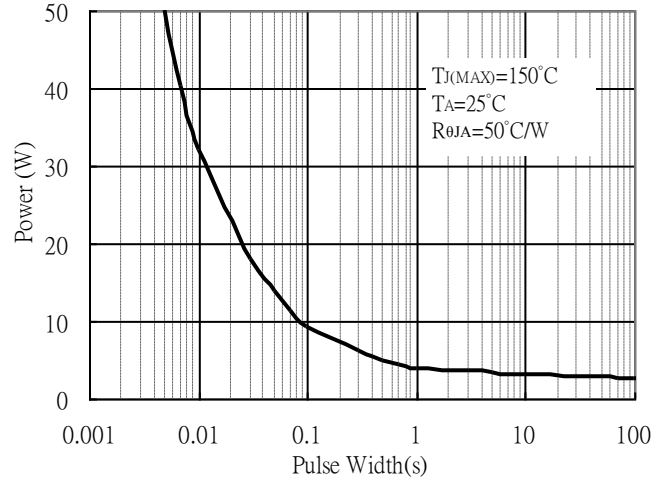


Typical Characteristics(Cont.) : Q1(N-channel)

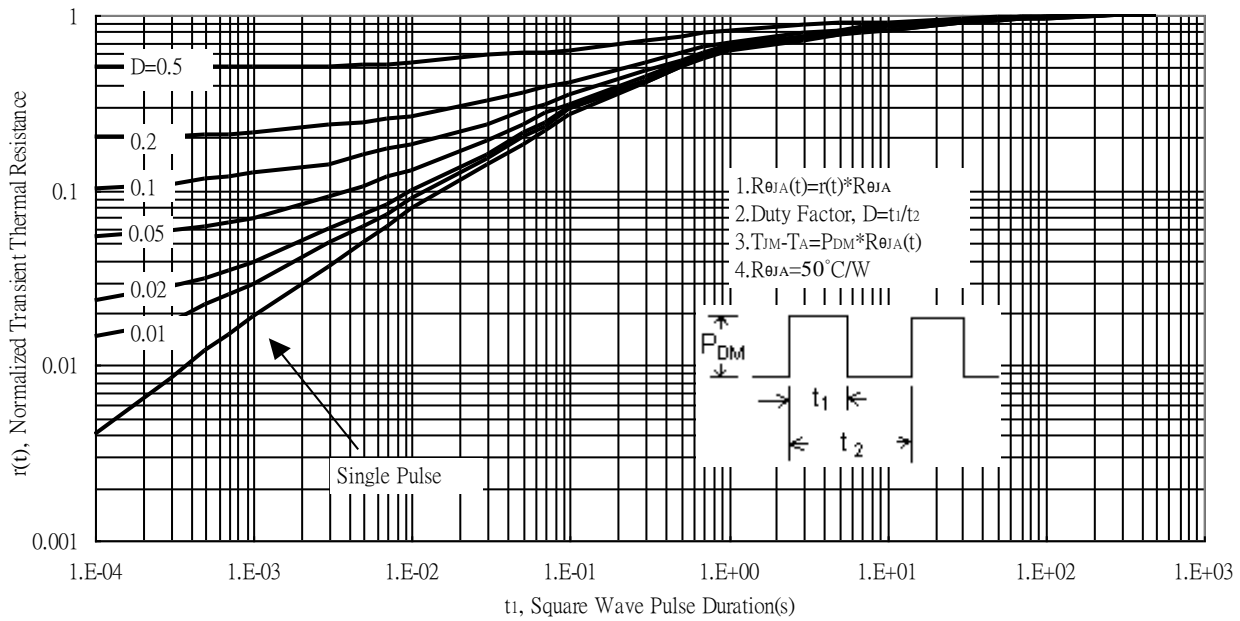
Typical Transfer Characteristics



Single Pulse Power Rating, Junction to Ambient
 (Note on page 2)



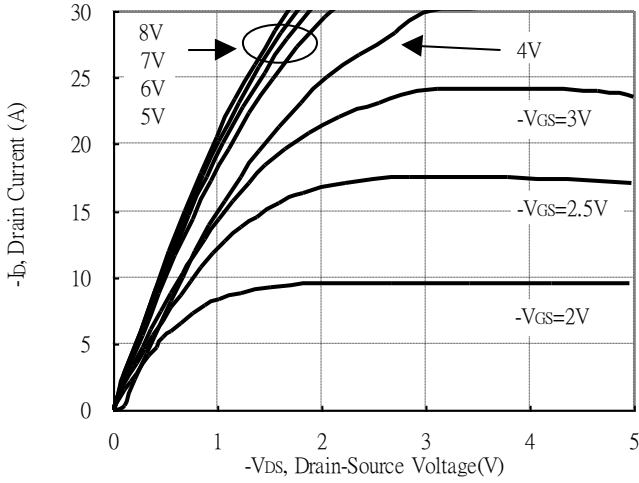
Transient Thermal Response Curves



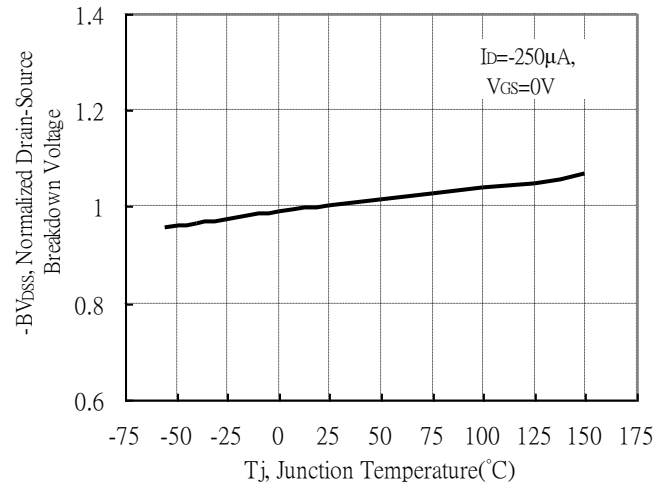


Typical Characteristics : Q2(P-channel)

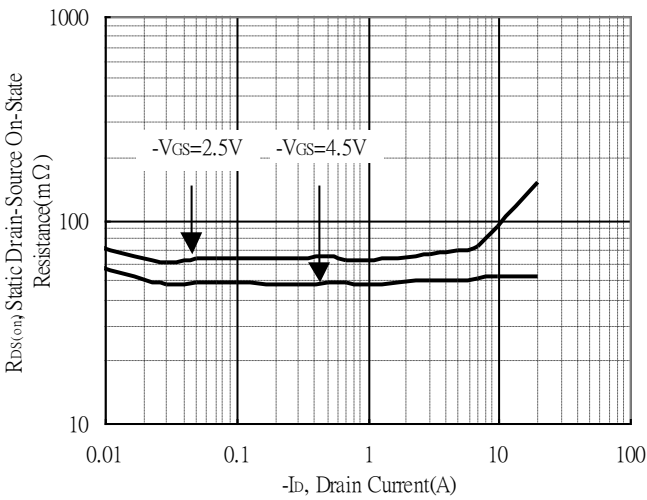
Typical Output Characteristics



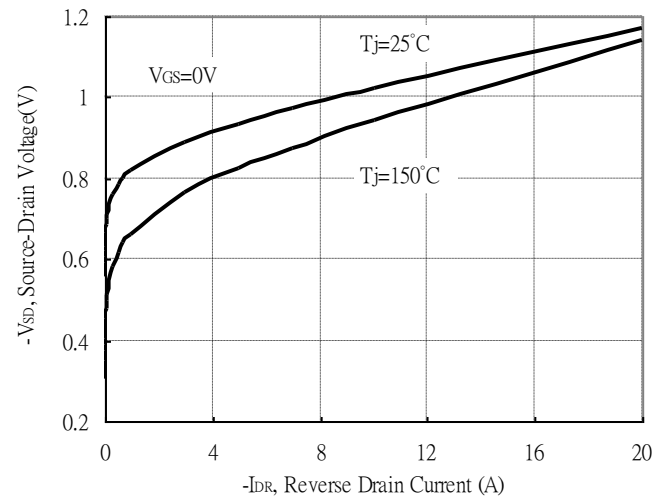
Breakdown Voltage vs Ambient Temperature



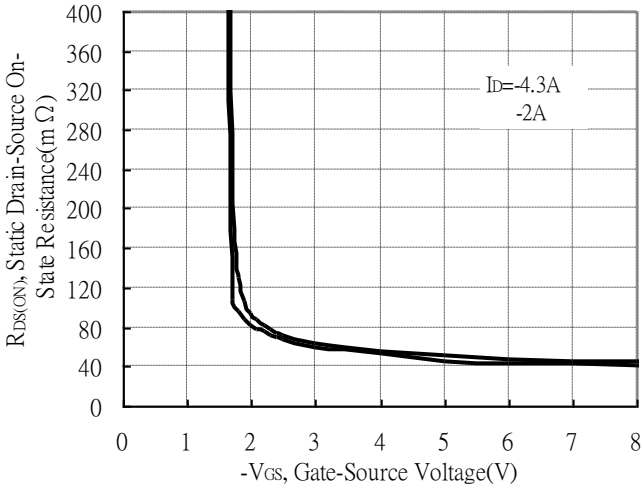
Static Drain-Source On-State resistance vs Drain Current



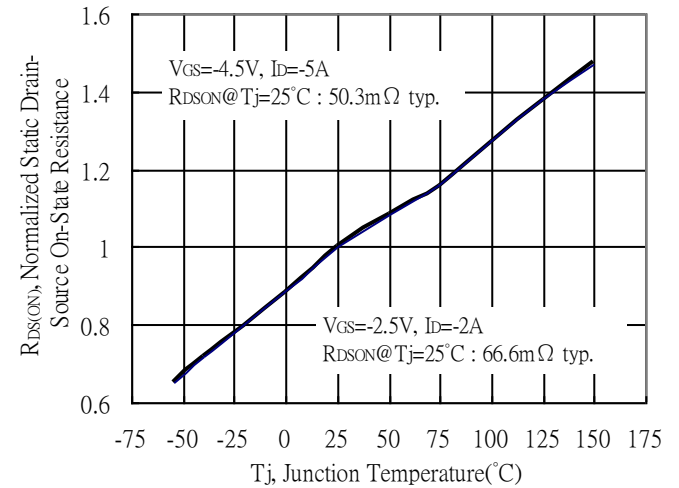
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

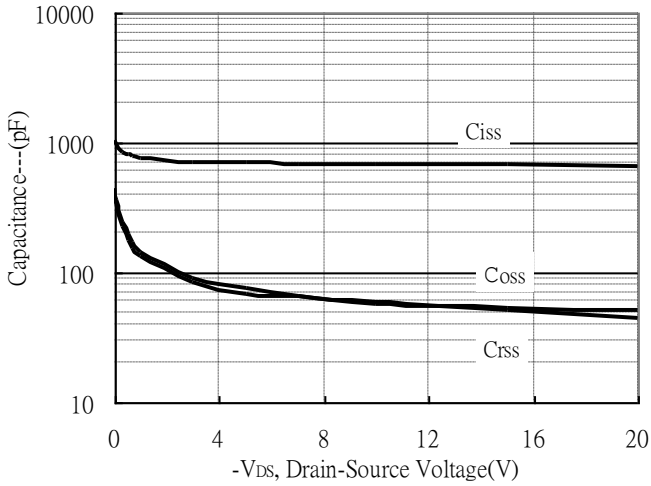


Drain-Source On-State Resistance vs Junction Temperature

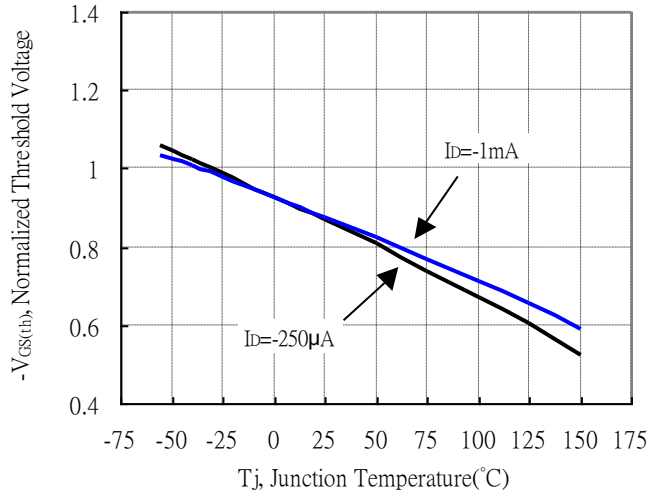


Typical Characteristics(Cont.) : Q2(P-channel)

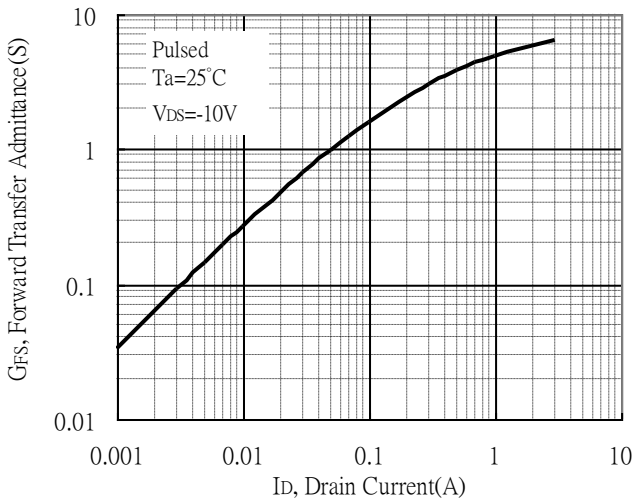
Capacitance vs Drain-to-Source Voltage



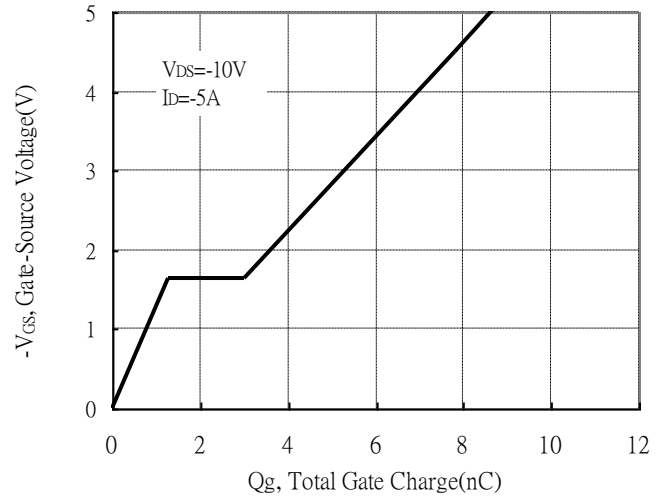
Threshold Voltage vs Junction Temperature



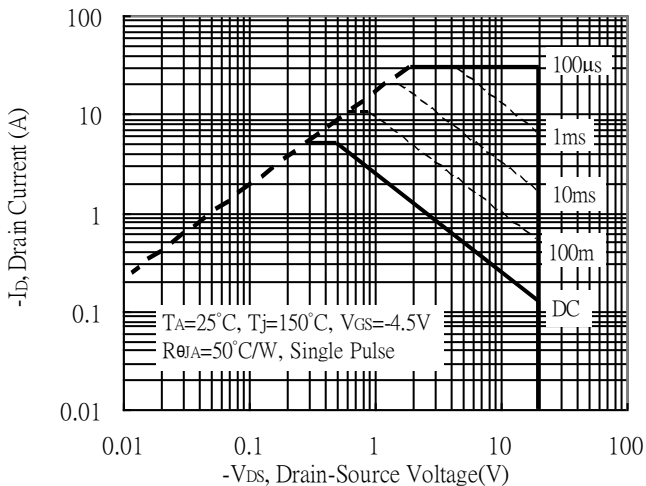
Forward Transfer Admittance vs Drain Current



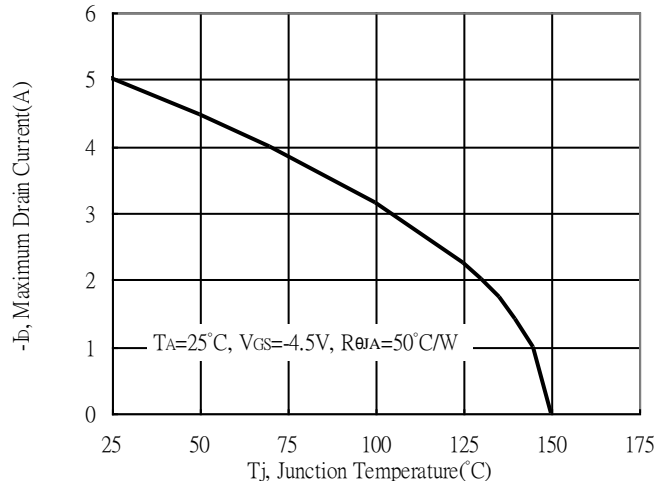
Gate Charge Characteristics



Maximum Safe Operating Area



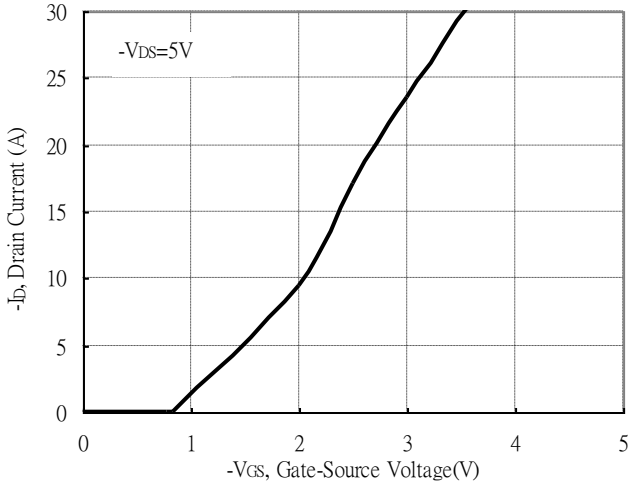
Maximum Drain Current vs Junction Temperature



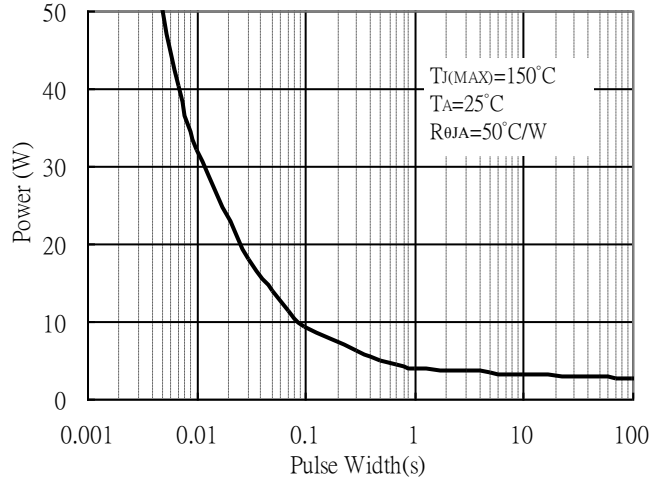


Typical Characteristics(Cont.) : Q2(P-channel)

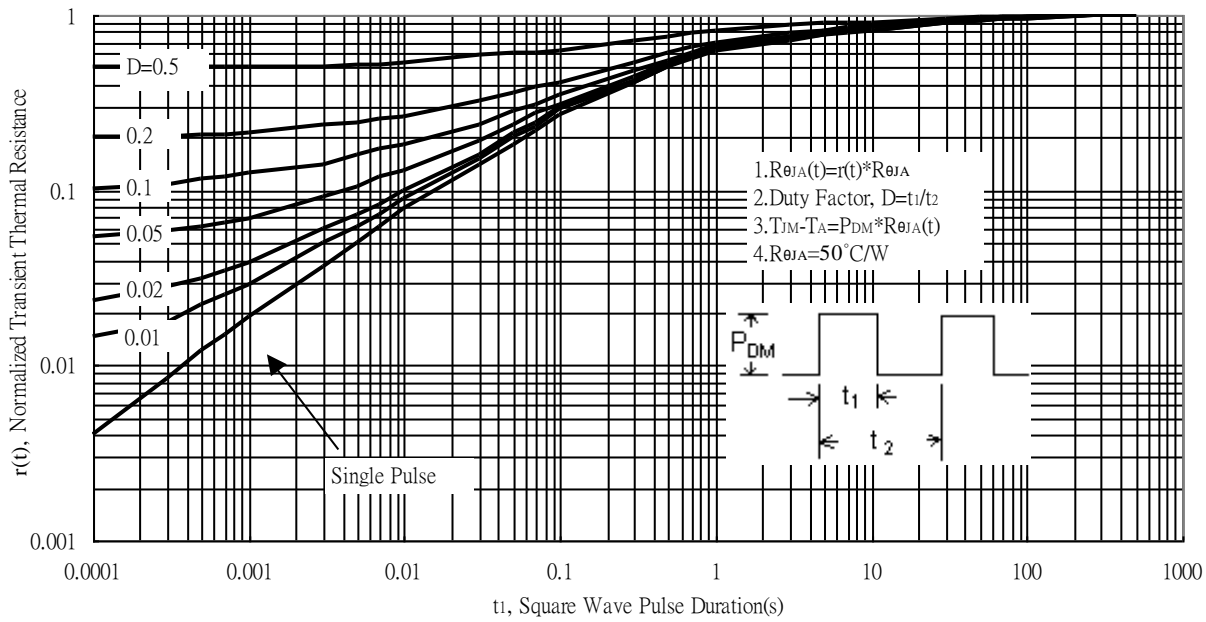
Typical Transfer Characteristics



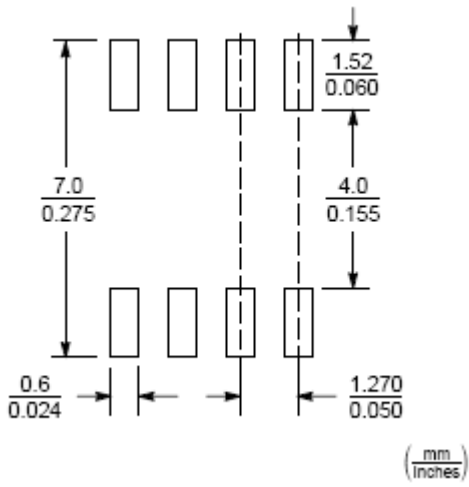
Single Pulse Power Rating, Junction to Ambient
 (Note on page 2)



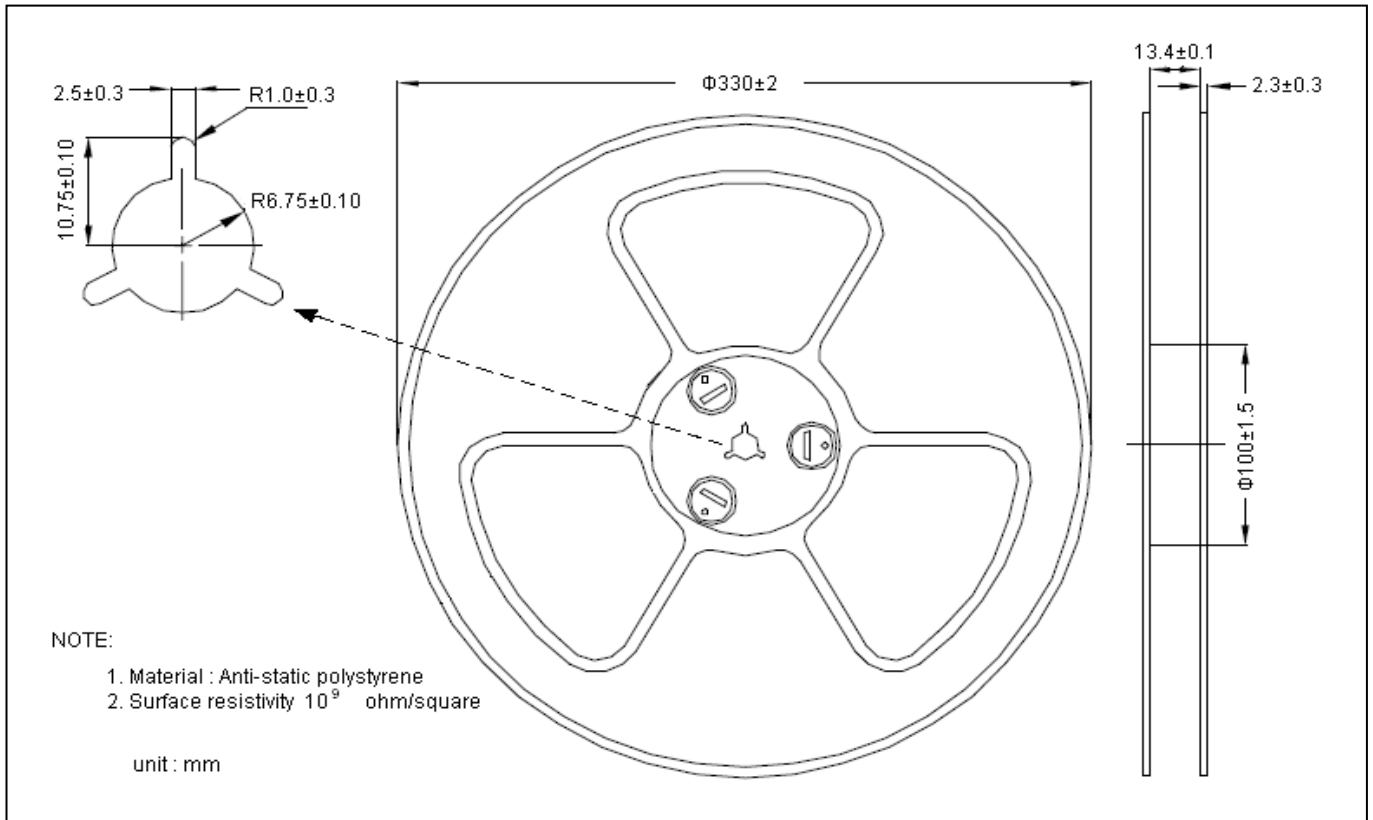
Transient Thermal Response Curves



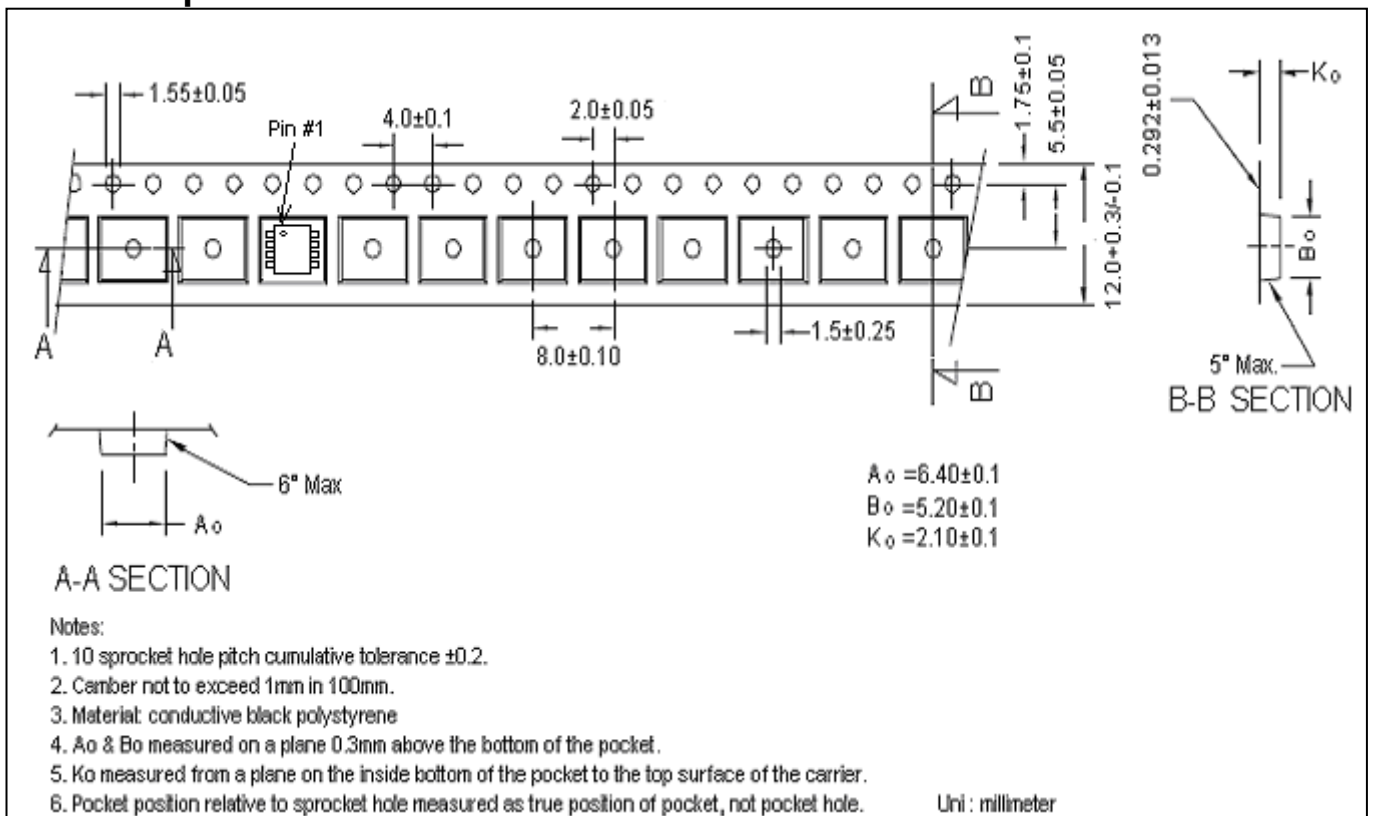
Recommended Soldering Footprint



Reel Dimension



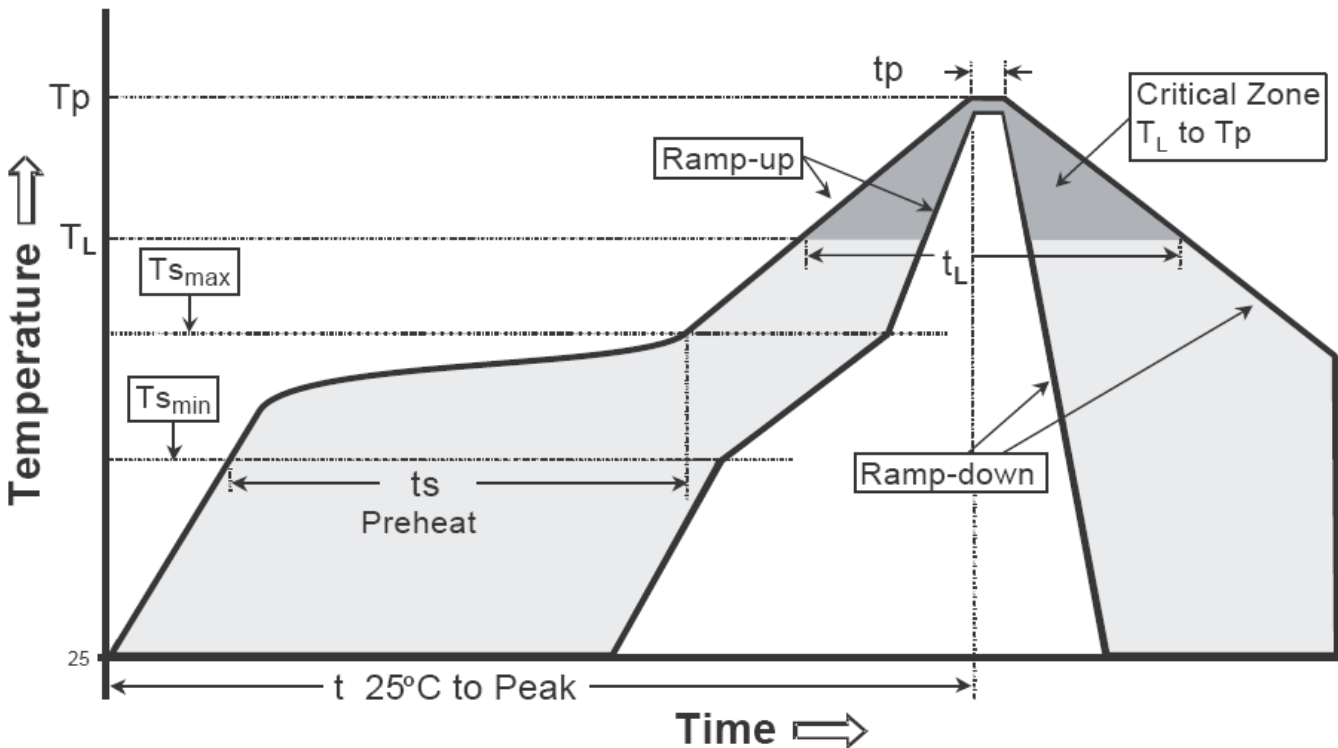
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

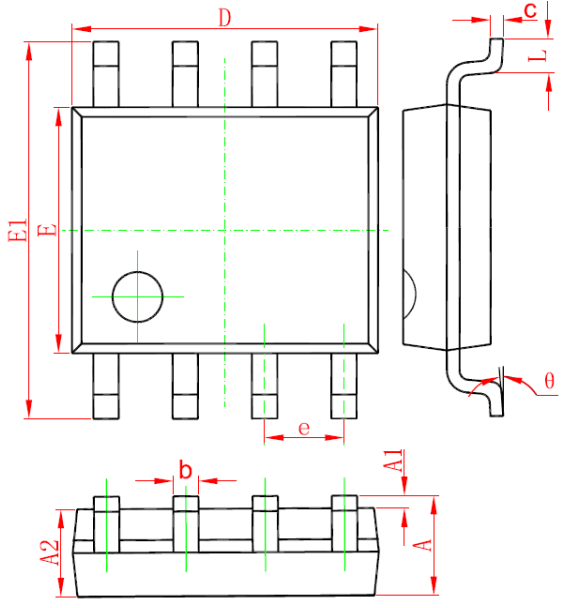
Recommended temperature profile for IR reflow



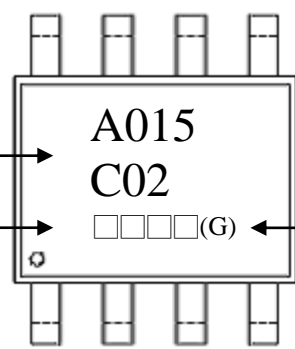
Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T _{s min})	100°C	150°C
-Temperature Max(T _{s max})	150°C	200°C
-Time(t _{s min} to t _{s max})	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T _L)	183°C	217°C
- Time (t _L)	60-150 seconds	60-150 seconds
Peak Temperature(T _p)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

SOP-8 Dimension



Marking:



Device Code → A015
 Date Code → C02
 Production site code → (G)

Date Code(counting from left to right) :
 1st code: year code, the last digit of Christian year
 2nd code : month code, Jan→A, Feb→B, Mar→C, Apr→D
 May→E, Jun→F, Jul→G, Aug→H, Sep→J,
 Oct→K, Nov→L, Dec→M
 3rd and 4th codes : production serial number, 01~99

Production site code : blank→ JCET, G →GEM

**8-Lead SOP-8 Plastic Package
 CYStek Package Code: Q8**

*: Typical

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069	E	3.800	4.000	0.150	0.157
A1	0.100	0.250	0.004	0.010	E1	5.800	6.200	0.228	0.244
A2	1.350	1.550	0.053	0.061	e	*1.270		*0.050	
b	0.330	0.510	0.013	0.020	L	0.400	1.270	0.016	0.050
c	0.170	0.250	0.006	0.010	θ	0°	8°	0°	8°
D	4.700	5.100	0.185	0.200					

- Notes:** 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

Important Notice:

- All rights are reserved. Reproduction in whole or in part is prohibited without the prior written approval of CYStek.
- CYStek reserves the right to make changes to its products without notice.
- CYStek **semiconductor products are not warranted to be suitable for use in Life-Support Applications, or systems.**
- CYStek assumes no liability for any consequence of customer product design, infringement of patents, or application assistance.